

## ISO122 Precision Lowest-Cost Isolation Amplifier

### 1 Features

- 100% Tested for High-Voltage Breakdown
- Rated 1500 Vrms
- High IMR: 140 dB at 60 Hz
- Bipolar Operation:  $V_O = \pm 10$  V
- 16-Pin Plastic DIP and 28-Lead SOIC
- Ease of Use: Fixed Unity Gain Configuration
- 0.020% Maximum Nonlinearity
- $\pm 4.5$ -V to  $\pm 18$ -V Supply Range

### 2 Applications

- Industrial Process Control:
  - Transducer Isolator, Isolator for Thermocouples, RTDs, Pressure Bridges, and Flow Meters, 4-mA to 20-mA Loop Isolation
- Ground Loop Elimination
- Motor and SCR Control
- Power Monitoring
- PC-Based Data Acquisition
- Test Equipment

### 3 Description

The ISO122 is a precision isolation amplifier incorporating a novel duty cycle modulation-demodulation technique. The signal is transmitted digitally across a 2-pF differential capacitive barrier. With digital modulation the barrier characteristics do not affect signal integrity, thus resulting in excellent reliability and good high-frequency transient immunity across the barrier. Both barrier capacitors are imbedded in the plastic body of the package.

The ISO122 is easy to use. No external components are required for operation. The key specifications are 0.020% maximum nonlinearity, 50-kHz signal bandwidth, and 200-V/ $^{\circ}$ C  $V_{OS}$  drift. A power supply range of 4.5 V to 18 V and quiescent currents of 5 mA on  $V_{S1}$  and  $\pm 5.5$  mA on  $V_{S2}$  make the ISO122 ideal for a wide range of applications.

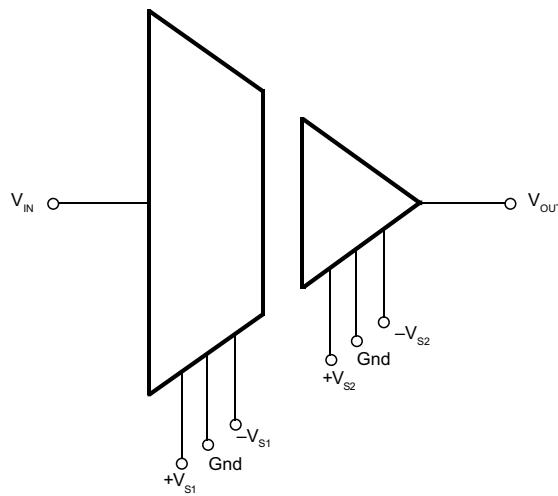
The ISO122 is available in 16-pin plastic DIP and 28-lead plastic surface-mount packages.

### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE   | BODY SIZE (NOM)           |
|-------------|-----------|---------------------------|
| ISO122      | PDIP (16) | 17.90 mm $\times$ 7.50 mm |
|             | SOIC (28) | 20.01 mm $\times$ 6.61 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### 4 Simplified Schematic



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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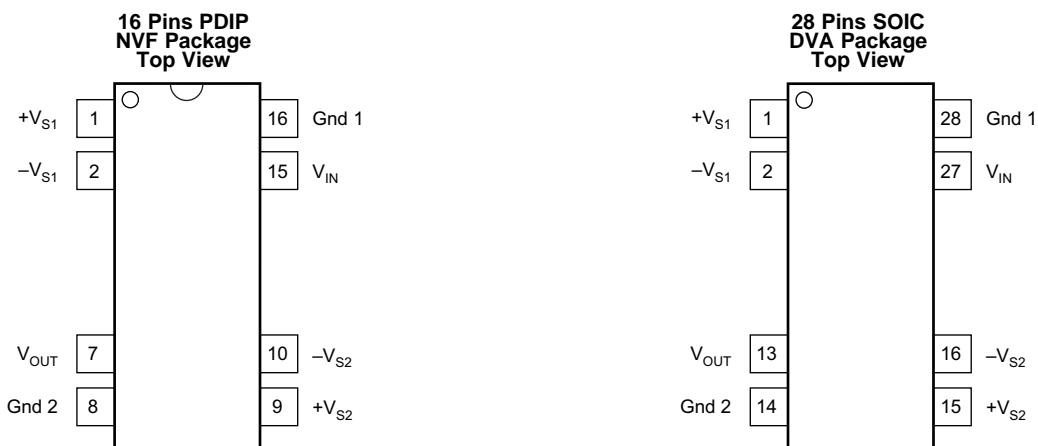
## 5 Revision History

### Changes from Original (November1993) to Revision A

Page

- Added *Pin Configuration and Functions* section, *ESD Ratings* table, *Feature Description* section, *Device Functional Modes*, *Application and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section ..... 1

## 6 Pin Configuration and Functions



### Pin Functions

| PIN              |      |      | I/O | DESCRIPTION                      |
|------------------|------|------|-----|----------------------------------|
| NAME             | PDIP | SOIC |     |                                  |
| GND              | 8    | 14   | -   | Low-side ground reference        |
| GND              | 16   | 28   | -   | High-side ground reference       |
| V <sub>IN</sub>  | 15   | 27   | I   | High-side analog input           |
| V <sub>OUT</sub> | 7    | 13   | O   | Low-side analog output           |
| +V <sub>S1</sub> | 1    | 1    | -   | High-side positive analog supply |
| -V <sub>S1</sub> | 2    | 2    | -   | High-side negative analog supply |
| +V <sub>S2</sub> | 9    | 15   | -   | Low-side positive analog supply  |
| -V <sub>S2</sub> | 10   | 16   | -   | Low-side negative analog supply  |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

|                                | MIN        | MAX | UNIT |
|--------------------------------|------------|-----|------|
| Supply voltage                 | ±18        |     | V    |
| $V_{IN}$                       | 100        |     | V    |
| Continuous isolation voltage   | 1500       |     | Vrms |
| Junction temperature           | 150        |     | °C   |
| Output short to common         | Continuous |     |      |
| Storage temperature, $T_{stg}$ | −40        | 125 | °C   |

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

|                                     | VALUE  | UNIT  |
|-------------------------------------|--|-------|
| $V_{(ESD)}$ Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±1000 |
|                                     | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±500  |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|      | MIN | NOM | MAX | UNIT |
|------|-----|-----|-----|------|
| TA   | −25 |     | 85  | °C   |
| +VS1 |     | 15  |     |      |
| −VS1 |     | −15 |     |      |
| +VS2 |     | 15  |     |      |
| −VS2 |     | −15 |     |      |
| VIN  |     | ±10 |     |      |

### 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> | ISO122                                       |            | UNIT |
|-------------------------------|--|------------|------|
|                               | NVF (PDIP)                                   | DVA (SOIC) |      |
|                               | 16 PINS                                      | 28 PINS    |      |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 51.0       | 79.8 |
| $R_{\theta JC(\text{top})}$   | Junction-to-case (top) thermal resistance    | 32.4       | 32.9 |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 29.5       | 42.2 |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 10.4       | 6.6  |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 29.0       | 40.9 |

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com).

## 7.5 Electrical Characteristics

At  $T_A = +25^\circ\text{C}$ ,  $V_{S1} = V_{S2} = \pm 15\text{ V}$ , and  $R_L = 2\text{ k}\Omega$ , unless otherwise noted.

| PARAMETER                        | TEST<br>CONDITIONS         | ISO122P/U |                       |             | ISO122JP/JU |                       |             | UNIT                           |
|----------------------------------|----------------------------|-----------|-----------------------|-------------|-------------|-----------------------|-------------|--------------------------------|
|                                  |                            | MIN       | TYP                   | MAX         | MIN         | TYP                   | MAX         |                                |
| <b>ISOLATION</b>                 |                            |           |                       |             |             |                       |             |                                |
| Voltage rated continuous ac 60Hz |                            | 1500      |                       |             | 1500        |                       |             | Vac                            |
| 100% Test <sup>(1)</sup>         | 1s, 5pc PD                 | 2400      |                       |             | 2400        |                       |             | Vac                            |
| Isolation Mode Rejection         | 60Hz                       |           | 140                   |             |             | 140                   |             | dB                             |
| Barrier Impedance                |                            |           | $10^{14} \parallel 2$ |             |             | $10^{14} \parallel 2$ |             | $\Omega \parallel \text{pF}$   |
| Leakage Current at 60Hz          | $V_{ISO} = 240\text{Vrms}$ | 0.18      | 0.5                   |             | 0.18        | 0.5                   |             | $\mu\text{A}_{\text{rms}}$     |
| <b>GAIN</b>                      |                            |           |                       |             |             |                       |             |                                |
| Nominal Gain                     | $V_O = \pm 10\text{V}$     |           | 1                     |             | 1           |                       |             | V/V                            |
| Gain Error                       |                            |           | $\pm 0.05$            | $\pm 0.50$  |             | $\pm 0.05$            | $\pm 0.50$  | %FSR                           |
| Gain vs Temperature              |                            |           | $\pm 10$              |             |             | $\pm 10$              |             | ppm/ $^\circ\text{C}$          |
| Nonlinearity <sup>(2)</sup>      |                            |           | $\pm 0.016$           | $\pm 0.020$ |             | $\pm 0.025$           | $\pm 0.050$ | %FSR                           |
| <b>INPUT OFFSET VOLTAGE</b>      |                            |           |                       |             |             |                       |             |                                |
| Initial Offset                   |                            |           | $\pm 20$              | $\pm 50$    |             | $\pm 20$              | $\pm 50$    | mV                             |
| vs Temperature                   |                            |           | $\pm 200$             |             |             | $\pm 200$             |             | $\mu\text{V}/^\circ\text{C}$   |
| vs Supply                        |                            |           | $\pm 2$               |             |             | $\pm 2$               |             | mV/V                           |
| Noise                            |                            |           | 4                     |             |             |                       |             | $\mu\text{V}/\sqrt{\text{Hz}}$ |
| <b>INPUT</b>                     |                            |           |                       |             |             |                       |             |                                |
| Voltage Range                    |                            |           | $\pm 10$              | $\pm 12.5$  |             | $\pm 10$              | $\pm 12.5$  | V                              |
| Resistance                       |                            |           | 200                   |             |             | 200                   |             | $\text{k}\Omega$               |
| <b>OUTPUT</b>                    |                            |           |                       |             |             |                       |             |                                |
| Voltage Range                    |                            |           | $\pm 10$              | $\pm 12.5$  |             | $\pm 10$              | $\pm 12.5$  | V                              |
| Current Drive                    |                            |           | $\pm 5$               | $\pm 15$    |             | $\pm 5$               | $\pm 15$    | mA                             |
| Capacitive Load Drive            |                            |           | 0.1                   |             |             | 0.1                   |             | $\mu\text{F}$                  |
| Ripple Voltage <sup>(3)</sup>    |                            |           | 20                    |             |             | 20                    |             | mVp-p                          |
| <b>FREQUENCY RESPONSE</b>        |                            |           |                       |             |             |                       |             |                                |
| Small-Signal Bandwidth           |                            |           | 50                    |             |             | 50                    |             | kHz                            |
| Slew Rate                        |                            |           | 2                     |             |             | 2                     |             | $\text{V}/\mu\text{s}$         |
| Settling Time 0.10%              | $V_O = \pm 10\text{V}$     |           | 50                    |             |             | 50                    |             | $\mu\text{s}$                  |
| Settling Time 0.01%              |                            |           | 350                   |             |             | 350                   |             | $\mu\text{s}$                  |
| Overload Recovery Time           |                            |           | 150                   |             |             | 150                   |             | $\mu\text{s}$                  |
| <b>POWER SUPPLIES</b>            |                            |           |                       |             |             |                       |             |                                |
| Rated Voltage                    |                            |           | $\pm 15$              |             |             | $\pm 15$              |             | V                              |
| Voltage Range                    |                            |           | $\pm 4.5$             | $\pm 18$    | $\pm 4.5$   | $\pm 18$              |             | V                              |
| $V_{S1}$                         | Quiescent Current          |           | $\pm 5$               | $\pm 7$     |             | $\pm 5$               | $\pm 7$     | mA                             |
| $V_{S2}$                         |                            |           | $\pm 5.5$             | $\pm 7$     |             | $\pm 5.5$             | $\pm 7$     |                                |
| <b>TEMPERATURE RANGE</b>         |                            |           |                       |             |             |                       |             |                                |
| Specification                    |                            |           | -25                   | 85          | -25         | 85                    |             | $^\circ\text{C}$               |
| Operating                        |                            |           | -25                   | 85          | -25         | 85                    |             | $^\circ\text{C}$               |
| Storage                          |                            |           | -40                   | 125         | -40         | 125                   |             | $^\circ\text{C}$               |
| $\theta_{JA}$                    | Thermal Resistance         |           | 100                   |             |             | 100                   |             | $^\circ\text{C}/\text{W}$      |
| $\theta_{JC}$                    |                            |           | 65                    |             |             | 65                    |             | $^\circ\text{C}/\text{W}$      |

(1) Tested at 1.6 X rated, fail on 5pC partial discharge.

(2) Nonlinearity is the peak deviation of the output voltage from the best-fit straight line. It is expressed as the ratio of deviation to FSR.

(3) Ripple frequency is at carrier frequency (500kHz).

## 7.6 Typical Characteristics

At  $T_A = +25^\circ\text{C}$ , and  $V_S = \pm 15 \text{ V}$ , unless otherwise noted.

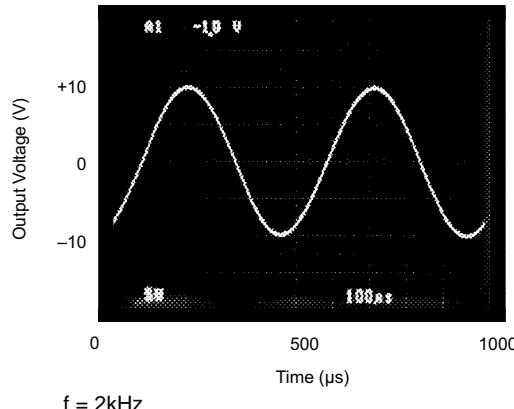


Figure 1. Sine Response

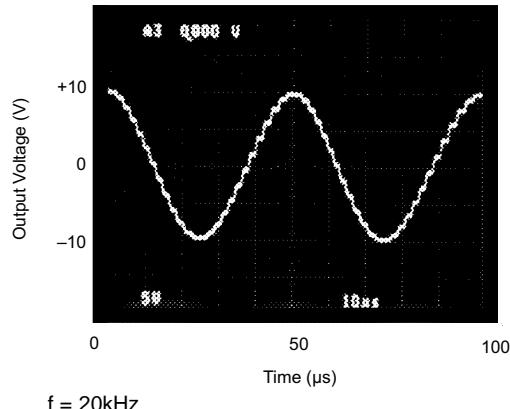


Figure 2. Sine Response

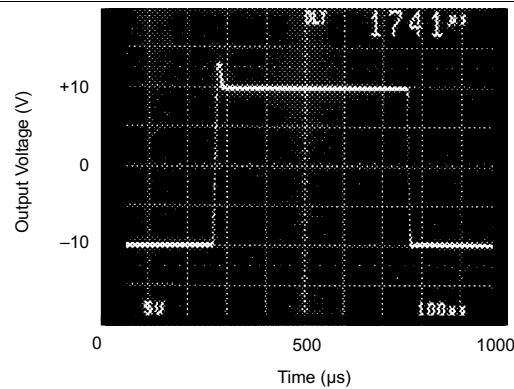


Figure 3. Step Response

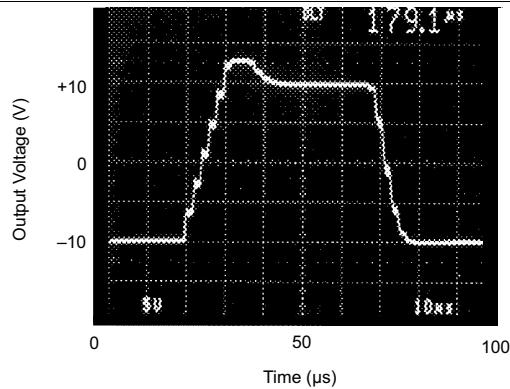


Figure 4. Step Response

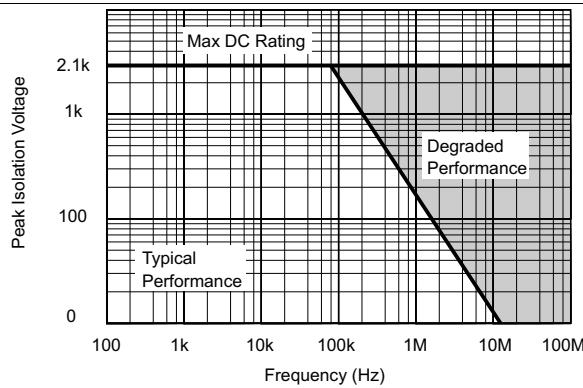


Figure 5. Isolation Voltage vs Frequency

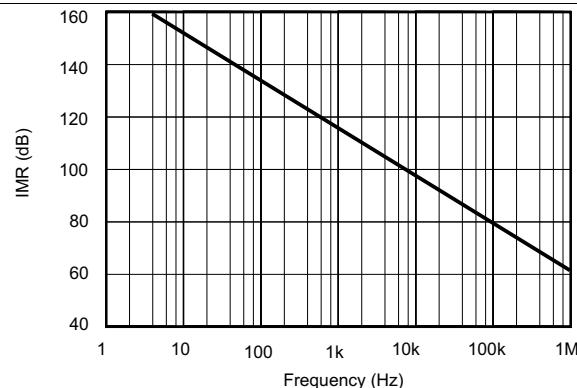


Figure 6. IMR vs Frequency

## Typical Characteristics (continued)

At  $T_A = +25^\circ\text{C}$ , and  $V_S = \pm 15 \text{ V}$ , unless otherwise noted.

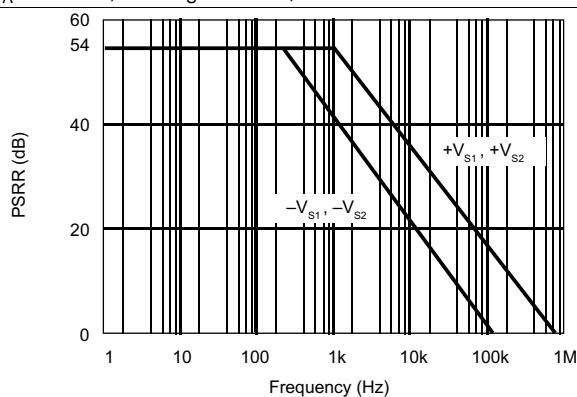


Figure 7. PSRR vs Frequency

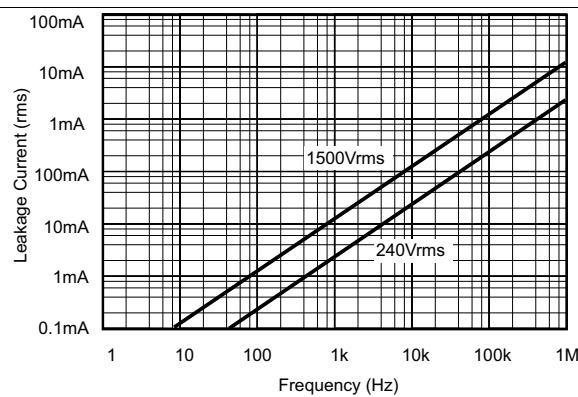


Figure 8. Isolation Leakage Current vs Frequency

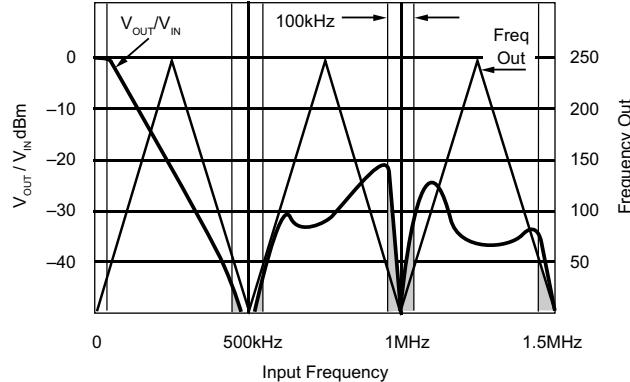


Figure 9. Signal Response to Inputs Greater than 250 kHz

## 8 Detailed Description

### 8.1 Overview

The ISO122 isolation amplifier uses an input and an output section galvanically isolated by matched 1-pF isolating capacitors built into the plastic package. The input is duty-cycle modulated and transmitted digitally across the barrier. The output section receives the modulated signal, converts it back to an analog voltage and removes the ripple component inherent in the demodulation. Input and output sections are fabricated, then laser trimmed for exceptional circuitry matching common to the input and output sections. The sections are then mounted on opposite ends of the package with the isolating capacitors mounted between the two sections. The ISO122 contains 250 transistors.

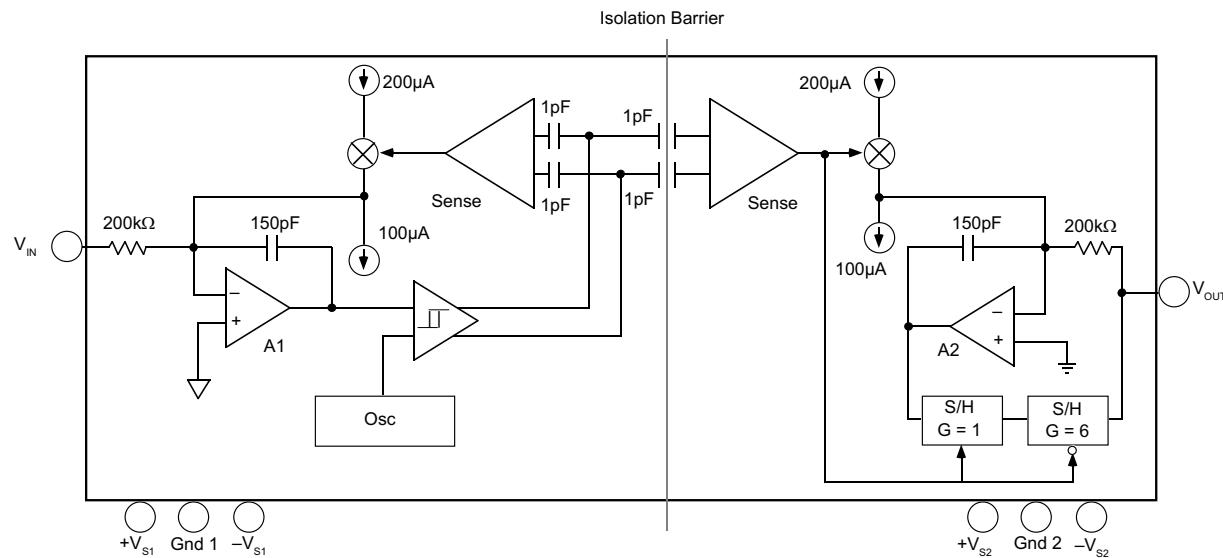
#### 8.1.1 Modulator

An input amplifier (A1, *Functional Block Diagram*) integrates the difference between the input current ( $V_{IN}/200\text{ k}\Omega$ ) and a switched  $\pm 100\text{-mA}$  current source. This current source is implemented by a switchable 200-mA source and a fixed 100- $\mu\text{A}$  current sink. To understand the basic operation of the modulator, assume that  $V_{IN} = 0\text{ V}$ . The integrator will ramp in one direction until the comparator threshold is exceeded. The comparator and sense amp will force the current source to switch; the resultant signal is a triangular waveform with a 50% duty cycle. The internal oscillator forces the current source to switch at 500 kHz. The resultant capacitor drive is a complementary duty-cycle modulation square wave.

#### 8.1.2 Demodulator

The sense amplifier detects the signal transitions across the capacitive barrier and drives a switched current source into integrator A2. The output stage balances the duty-cycle modulated current against the feedback current through the 200 k $\Omega$  feedback resistor, resulting in an average value at the  $V_{OUT}$  pin equal to  $V_{IN}$ . The sample and hold amplifiers in the output feedback loop serve to remove undesired ripple voltages inherent in the demodulation process.

## 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Isolation Amplifier

The ISO122 is a precision analog isolation amplifier. The input signal is transmitted digitally across a high-voltage differential capacitive barrier. With digital modulation the barrier characteristics do affect signal integrity, resulting in excellent reliability and high-frequency transient immunity.

## 8.4 Device Functional Modes

The ISO122 does not have any additional functional modes.

# 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 9.1 Application Information

### 9.1.1 Carrier Frequency Considerations

The ISO122 amplifier transmits the signal across the isolation barrier by a 500kHz duty cycle modulation technique. For input signals having frequencies below 250 kHz, this system works like any linear amplifier. But for frequencies above 250 kHz, the behavior is similar to that of a sampling amplifier. The signal response to inputs greater than 250 kHz performance curve shows this behavior graphically; at input frequencies above 250 kHz the device generates an output signal component of reduced magnitude at a frequency below 250 kHz. This is the aliasing effect of sampling at frequencies less than two times the signal frequency (the Nyquist frequency). At the carrier frequency and its harmonics, both the frequency and amplitude of the aliasing go to zero.

### 9.1.2 Isolation Mode Voltage Induced Errors

IMV can induce errors at the output as indicated by the plots of IMV vs Frequency. It should be noted that if the IMV frequency exceeds 250 kHz, the output also will display spurious outputs (aliasing), in a manner similar to that for  $V_{IN} > 250$  kHz and the amplifier response will be identical to that shown in the Signal Response to Inputs Greater Than 250-kHz performance curve. This occurs because IMV-induced errors behave like input-referred error signals. To predict the total error, divide the isolation voltage by the IMR shown in the IMR vs Frequency curve and compute the amplifier response to this input-referred error signal from the data given in the Signal Response to Inputs Greater than 250-kHz performance curve. For example, if a 800-kHz 1000-Vrms IMR is present, then a total of  $[(-60 \text{ dB}) + (-30 \text{ dB})] \times (1000 \text{ V}) = 32\text{-mV}$  error signal at 200 kHz plus a 1 V, 800-kHz error signal will be present at the output.

### 9.1.3 High IMV dV/dt Errors

As the IMV frequency increases and the dV/dt exceeds 1000 V/μs, the sense amp may start to false trigger, and the output will display spurious errors. The common-mode current being sent across the barrier by the high slew rate is the cause of the false triggering of the sense amplifier. Lowering the power-supply voltages below  $\pm 15$  V may decrease the dV/dt to 500 V/μs for typical performance.

### 9.1.4 High Voltage Testing

Texas Instruments has adopted a partial discharge test criterion that conforms to the German VDE0884 Optocoupler Standards. This method requires the measurement of minute current pulses ( $< 5$  pC) while applying 2400-Vrms, 60-Hz high-voltage stress across every ISO122 isolation barrier. No partial discharge may be initiated to pass this test. This criterion confirms transient overvoltage ( $1.6 \times 1500$  Vrms) protection without damage to the ISO122. Lifetest results verify the absence of failure under continuous rated voltage and maximum temperature.

This new test method represents the “state of the art” for nondestructive high-voltage reliability testing. It is based on the effects of nonuniform fields that exist in heterogeneous dielectric material during barrier degradation. In the case of void nonuniformities, electric field stress begins to ionize the void region before bridging the entire high-voltage barrier. The transient conduction of charge during and after the ionization can be detected externally as a burst of 0.01–0.1 ms current pulses that repeat on each AC voltage cycle. The minimum AC barrier voltage that initiates partial discharge is defined as the “inception voltage.” Decreasing the barrier voltage to a lower level is required before partial discharge ceases and is defined as the “extinction voltage.” The

## Application Information (continued)

package insulation processes have been characterized and developed to yield an inception voltage in excess of 2400 Vrms so that transient overvoltages below this level will not damage the ISO122. The extinction voltage is above 1500 Vrms so that even overvoltage induced partial discharge will cease once the barrier voltage is reduced to the 1500 Vrms (rated) level. Older high-voltage test methods relied on applying a large enough overvoltage (above rating) to break down marginal parts, but not so high as to damage good ones. Our new partial discharge testing gives us more confidence in barrier reliability than breakdown/no breakdown criteria.

## 9.2 Typical Application

### 9.2.1 Output Filter

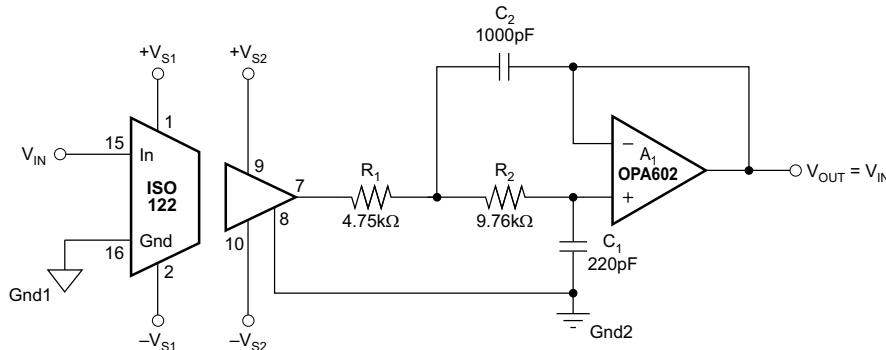


Figure 10. ISO122 With Output Filter for Improved Ripple

#### 9.2.1.1 Design Requirements

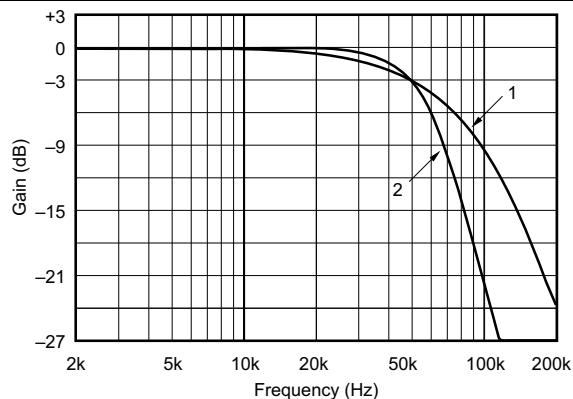
The ISO122 isolation amplifiers (ISO amps) have a small (10 to 20 mVp-p typical) residual demodulator ripple at the output. A simple filter can be added to eliminate the output ripple without decreasing the 50-kHz signal bandwidth of the ISO amp.

#### 9.2.1.2 Detailed Design Procedure

The ISO122 is designed to have a 50-kHz single-pole (Butterworth) signal response. By cascading the ISO amp with a simple 50-kHz,  $Q = 1$ , two-pole, low-pass filter, the overall signal response becomes three-pole Butterworth. The result is a maximally flat 50-kHz magnitude response and the output ripple reduced below the noise level. Figure 10 shows the complete circuit. The two-pole filter is a unity-gain Sallen-Key type consisting of A1, R1, R2, C1, and C2. The values shown give  $Q = 1$  and f-3-dB bandwidth = 50 kHz. Because the op amp is connected as a unity-gain follower, gain and gain accuracy of the ISO amp are unaffected. Using a precision op amp such as the OPA602 also preserves the DC accuracy of the ISO amp.

## Typical Application (continued)

### 9.2.1.3 Application Curves



- 1) Standard ISO122 has 50kHz single-pole (Butterworth) response.
- 2) ISO122 with cascaded 50kHz,  $Q = 1$ , two-pole, low-pass filter has three-pole Butterworth response.

Figure 11. Gain vs. Frequency

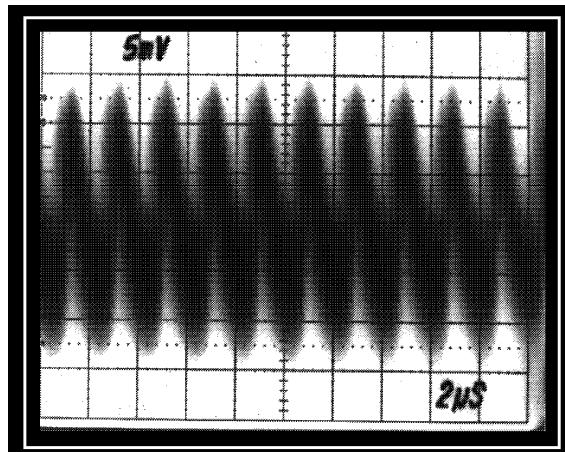


Figure 12. Standard ISO122 (Approximately 20-mVp-p Output Ripple)

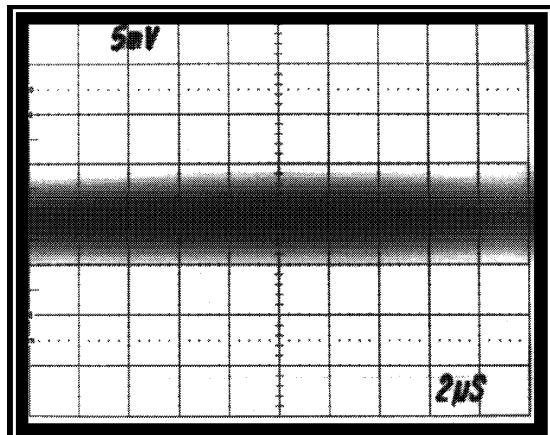


Figure 13. Filtered ISO122 (No Visible Output Ripple)

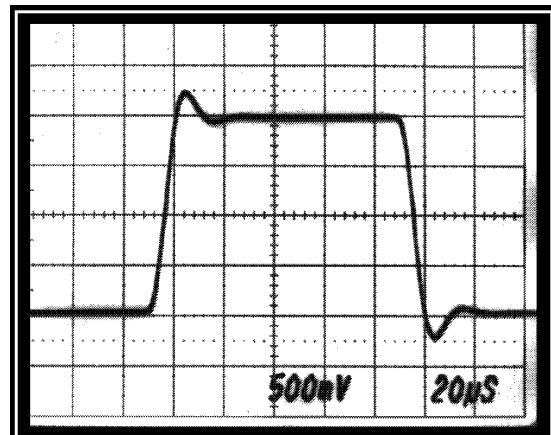


Figure 14. Step Response of Standard ISO122

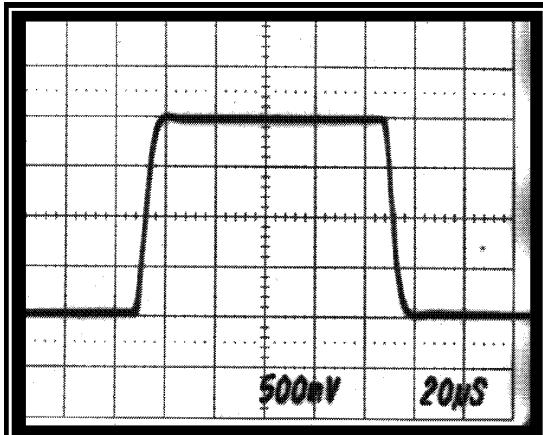


Figure 15. Step Response of ISO122 With Added Twopole Output Filter

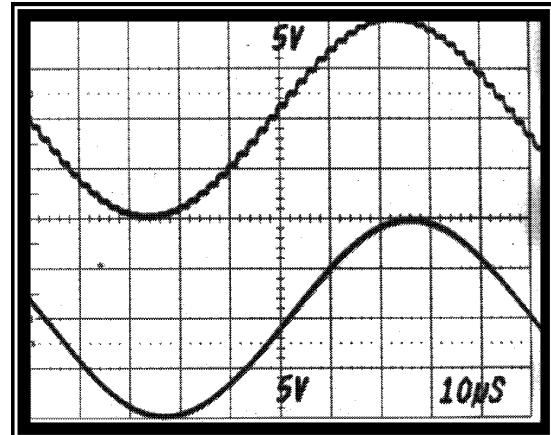
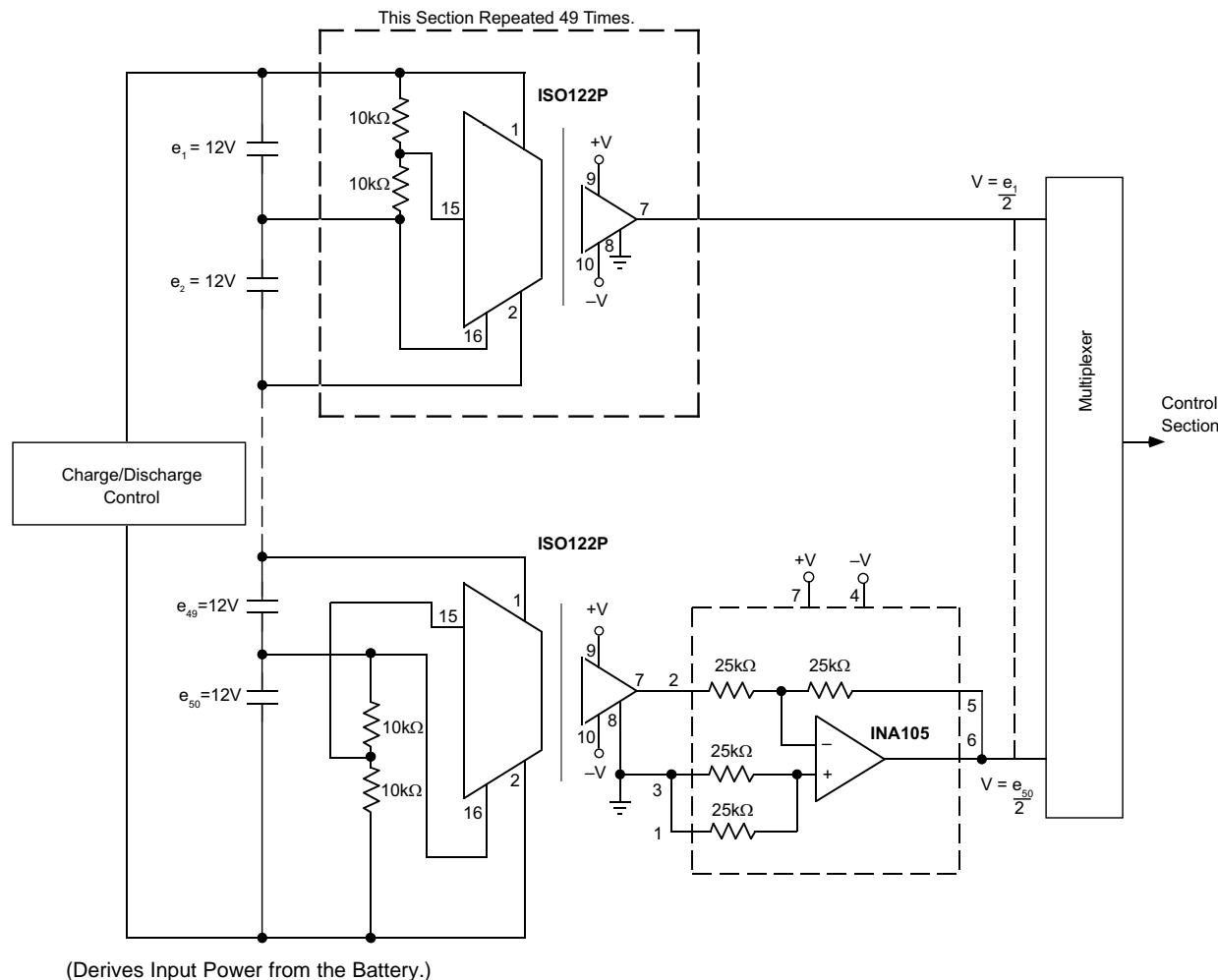


Figure 16. Large-signal, 10 kHz Sine-wave Response of ISO122 With and Without Output Filter

## Typical Application (continued)

### 9.2.2 Battery Monitor

Figure 17 provides a means to monitor the cell voltage on a 600-V battery stack by using the battery as a power source for the isolated voltage.



**Figure 17. Battery Monitor for a 600-V Battery Power System**

## Typical Application (continued)

### 9.2.3 Programmable Gain Amplifier

In applications where variable gain configurations are required, a programmable gain amplifier like the PGA102 can be used with the ISO122. Figure 18 uses an ISO150 to provide gain pin selection options to the PGA102.

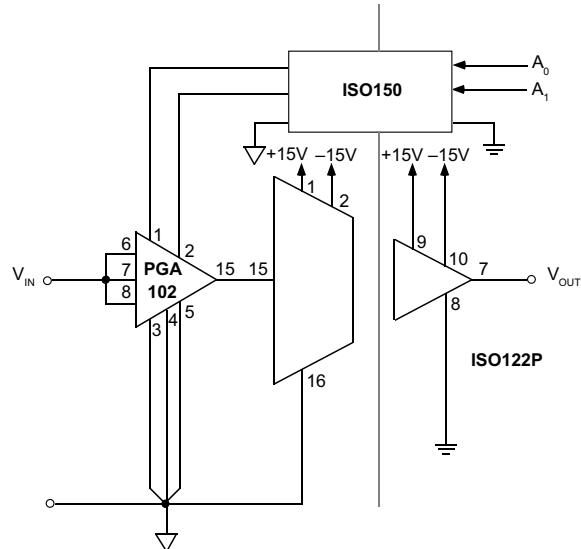
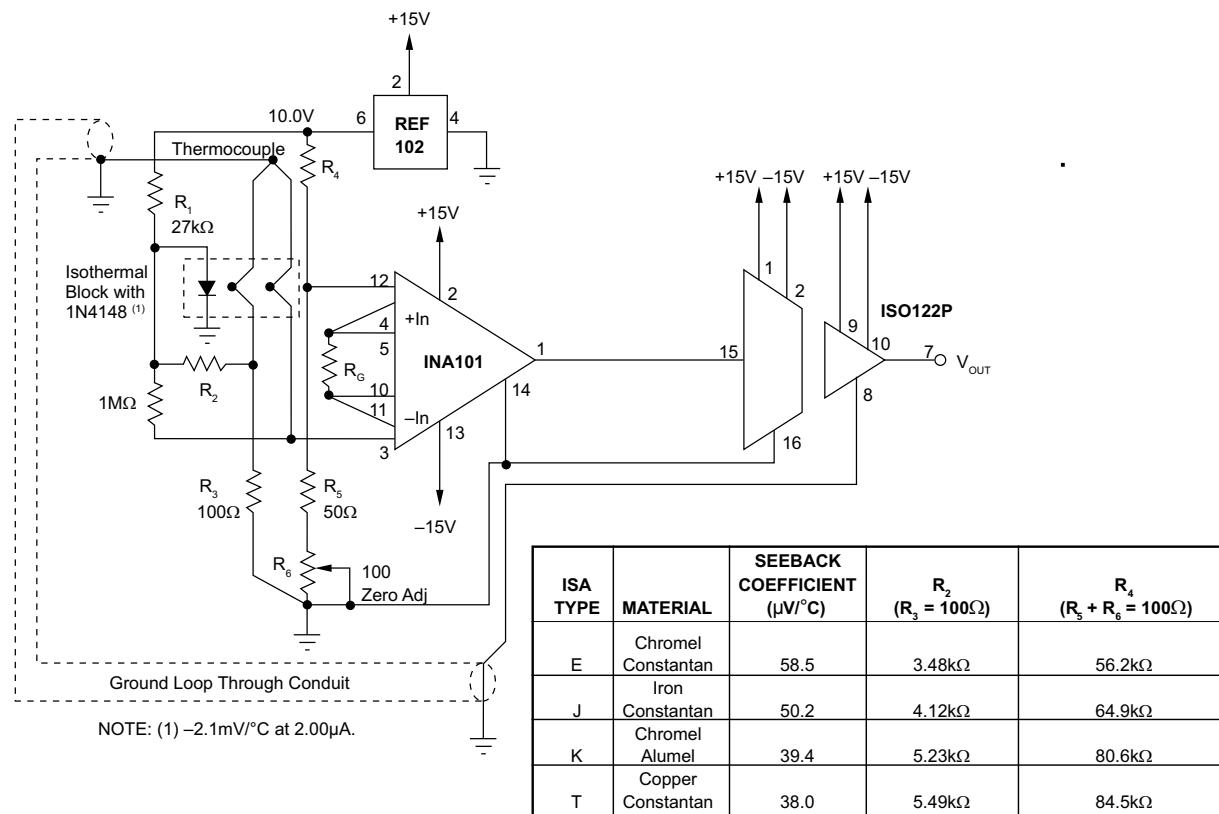


Figure 18. Programmable-Gain Isolation Channel With Gains of 1, 10, and 100

## Typical Application (continued)

### 9.2.4 Thermocouple Amplifier

For isolated temperature measurements, [Figure 19](#) provides an application solution using the INA101 feeding the input stage of the ISO122. The table provides suggested resistor values based on the type of thermistor used in the application.

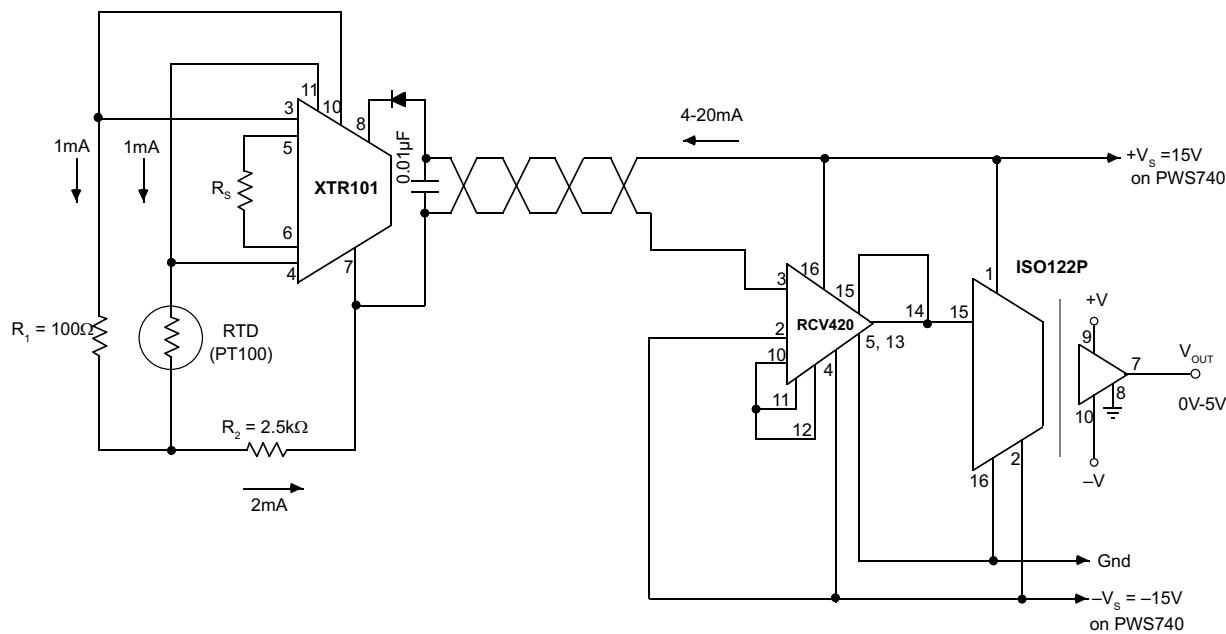


**Figure 19. Thermocouple Amplifier With Ground Loop Elimination, Cold Junction Compensation, and Up-scale Burn-out.**

## Typical Application (continued)

### 9.2.5 Isolated 4- to 20-mA Instrument Loop

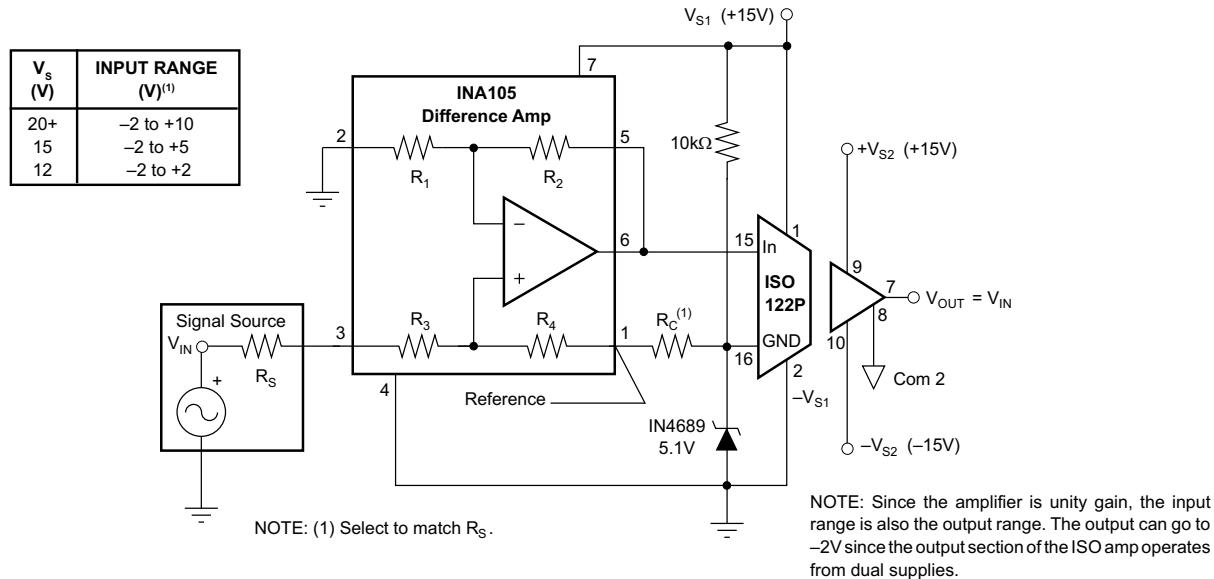
For isolated temperature measurements in a 4- to 20-mA loop, Figure 20 provides a solution using the XTR101 and RCV420. A high-performance PT100 resistance temperature detector (RTD) provides the user with an isolated 0- to 5-V representation of the isolated temperature measurement.



**Figure 20. Isolated 4- to 200-mA Instrument Loop. (RTD shown.)**

### 9.2.6 Single-Supply Operation of the ISO122P Isolation Amplifier

The circuit shown in Figure 21 uses a 5.1-V Zener diode to generate the negative supply for an ISO122 from a single supply on the high-voltage side of the isolation amplifier. The input measuring range will be dependent on the applied voltage as noted in the accompanying table.



For additional information see SBOA004.

**Figure 21. Single-Supply Operation of the ISO122P Isolation Amplifier**

## Typical Application (continued)

### 9.2.7 Input-Side Powered ISO Amp

The user side of the ISO122 can be powered from the high-voltage side using an isolated DC-DC converter as shown in Figure 22.

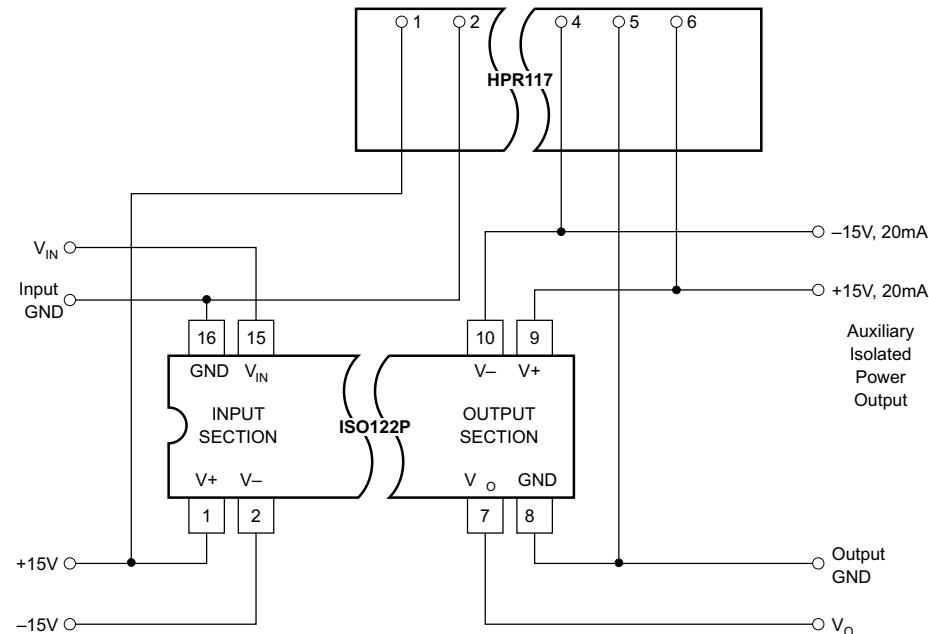


Figure 22. Input-Side Powered ISO Amp

### 9.2.8 Powered ISO Amp With Three-Port Isolation

Figure 23 shows an application solution that provides isolated power to both the user and high-voltage sides of the ISO122 amplifier.

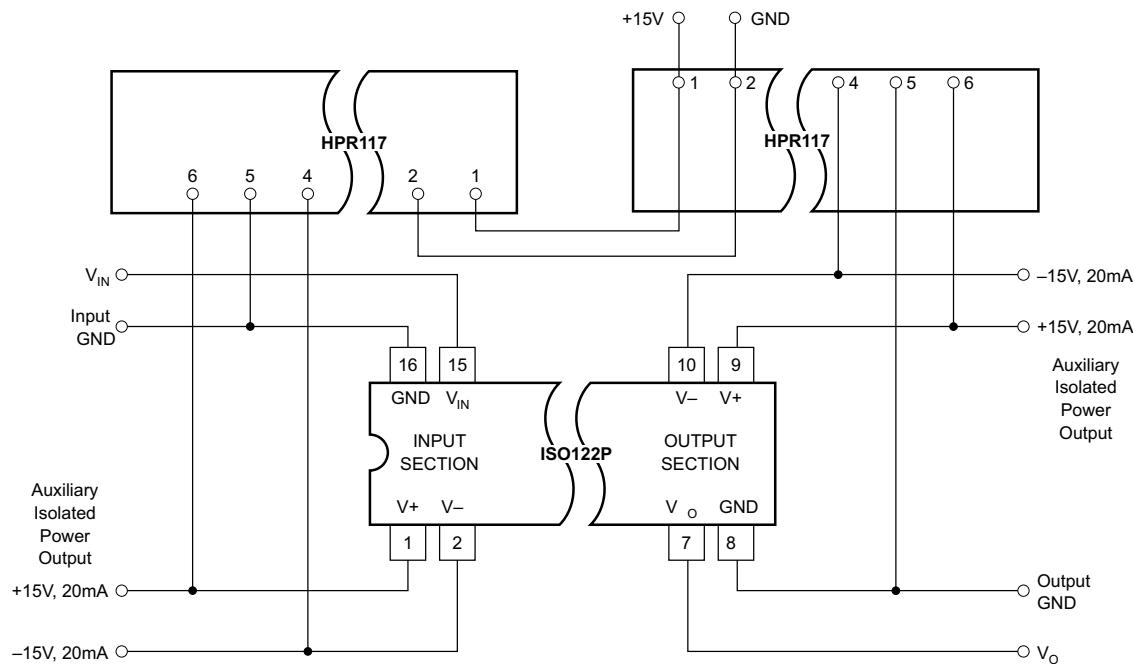


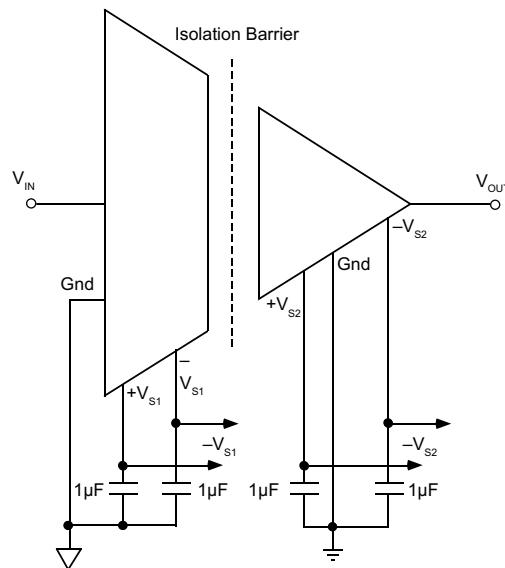
Figure 23. Powered ISO Amp With Three-Port Isolation

## 10 Power Supply Recommendations

### 10.1 Signal and Supply Connections

Each power-supply pin should be bypassed with 1- $\mu$ F tantalum capacitors located as close to the amplifier as possible. The internal frequency of the modulator/demodulator is set at 500 kHz by an internal oscillator. Therefore, if it is desired to minimize any feedthrough noise (beat frequencies) from a DC-DC converter, use a  $\pi$  filter on the supplies (see [Figure 24](#)). The ISO122 output has a 500-kHz ripple of 20 mV, which can be removed with a simple 2-pole low-pass filter with a 100-kHz cutoff using a low-cost op amp (see [Figure 10](#)).

The input to the modulator is a current (set by the 200-k $\Omega$  integrator input resistor) that makes it possible to have an input voltage greater than the input supplies, as long as the output supply is at least  $\pm 15$  V. It is therefore possible, when using an unregulated DC-DC converter, to minimize PSR related output errors with  $\pm 5$ -V voltage regulators on the isolated side and still get the full  $\pm 10$ V input and output swing.



**Figure 24. Basic Signal and Power Connections**

## 11 Layout

### 11.1 Layout Guidelines

To maintain the isolation barrier of the device, the distance between the high-side ground (pin 16 or 28) and the low-side ground (pin 8 or 14) should be kept at maximum; that is, the entire area underneath the device should be kept free of any conducting materials.

### 11.2 Layout Example

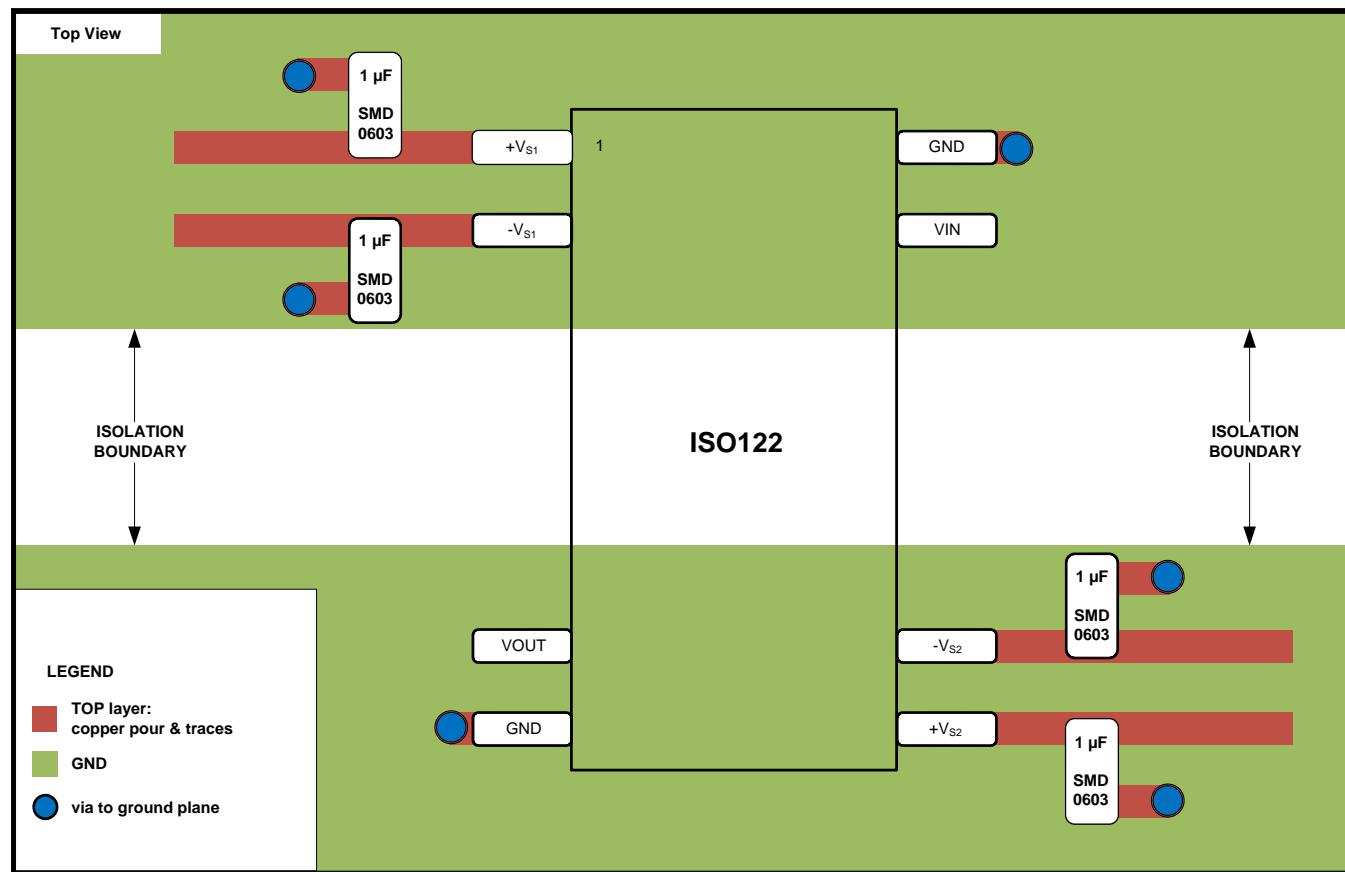


Figure 25. Typical Layout

## 12 Device and Documentation Support

### 12.1 Trademarks

All trademarks are the property of their respective owners.

### 12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.3 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

| Orderable part number       | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">ISO122JP</a>    | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122JP            |
| ISO122JP.A                  | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122JP            |
| ISO122JPE4                  | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122JP            |
| <a href="#">ISO122JU</a>    | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122JU            |
| ISO122JU.A                  | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122JU            |
| <a href="#">ISO122JU/1K</a> | Active        | Production           | SOIC (DVA)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122JU            |
| ISO122JU/1K.A               | Active        | Production           | SOIC (DVA)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122JU            |
| ISO122JUE4                  | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122JU            |
| <a href="#">ISO122P</a>     | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122P             |
| ISO122P.A                   | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122P             |
| ISO122PE4                   | Active        | Production           | PDIP (NVF)   8 | 25   TUBE             | Yes         | NIPDAU                               | N/A for Pkg Type                  | -25 to 85    | ISO122P             |
| <a href="#">ISO122U</a>     | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122U             |
| ISO122U.A                   | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122U             |
| <a href="#">ISO122U/1K</a>  | Active        | Production           | SOIC (DVA)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122U             |
| ISO122U/1K.A                | Active        | Production           | SOIC (DVA)   8 | 1000   LARGE T&R      | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122U             |
| ISO122UE4                   | Active        | Production           | SOIC (DVA)   8 | 20   TUBE             | Yes         | NIPDAU                               | Level-3-260C-168 HR               | -25 to 85    | ISO122U             |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

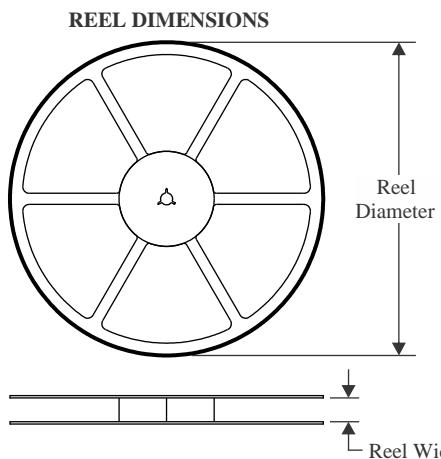
<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

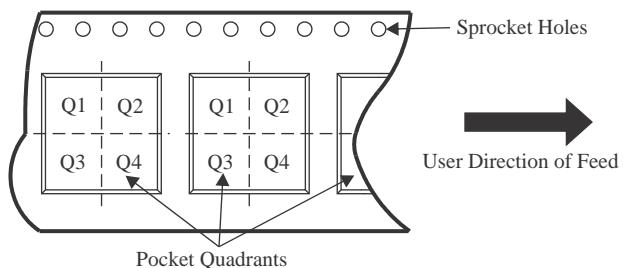
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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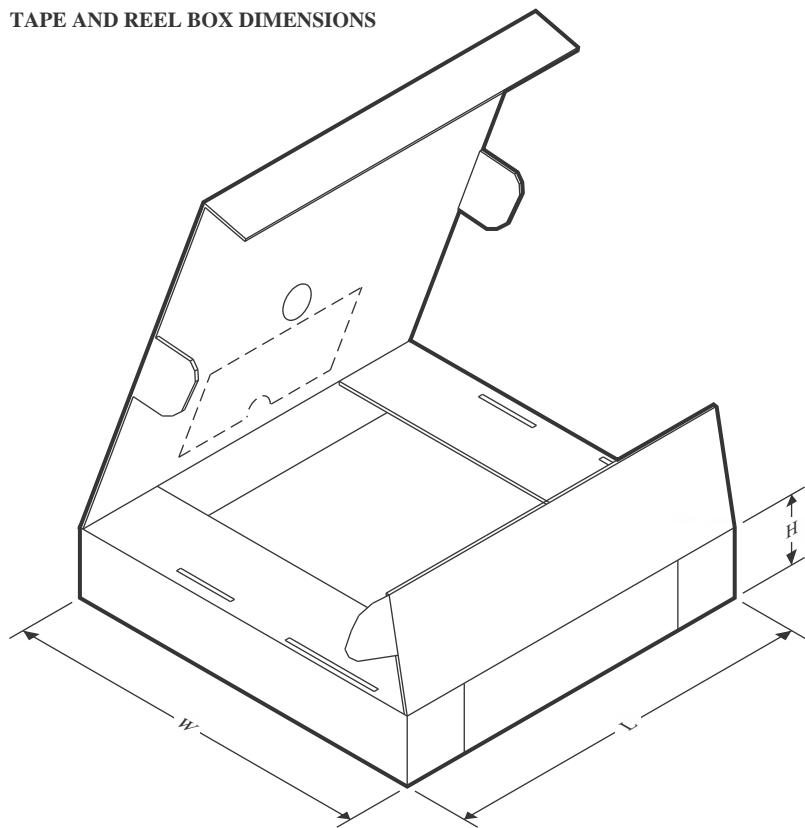
**TAPE AND REEL INFORMATION**


|    |   |
|----|---|
| A0 | Dimension designed to accommodate the component width     |
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


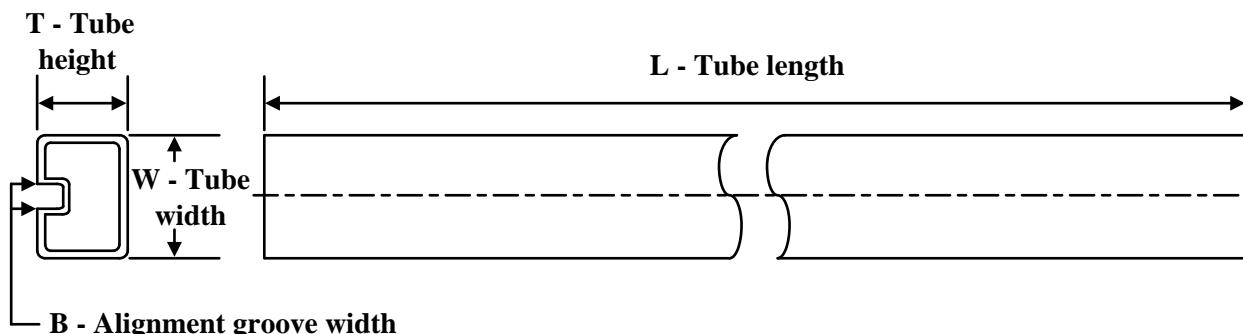
\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ISO122JU/1K | SOIC         | DVA             | 8    | 1000 | 330.0              | 24.4               | 10.9    | 18.3    | 3.2     | 12.0    | 24.0   | Q1            |
| ISO122U/1K  | SOIC         | DVA             | 8    | 1000 | 330.0              | 24.4               | 10.9    | 18.3    | 3.2     | 12.0    | 24.0   | Q1            |

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ISO122JU/1K | SOIC         | DVA             | 8    | 1000 | 356.0       | 356.0      | 45.0        |
| ISO122U/1K  | SOIC         | DVA             | 8    | 1000 | 356.0       | 356.0      | 45.0        |

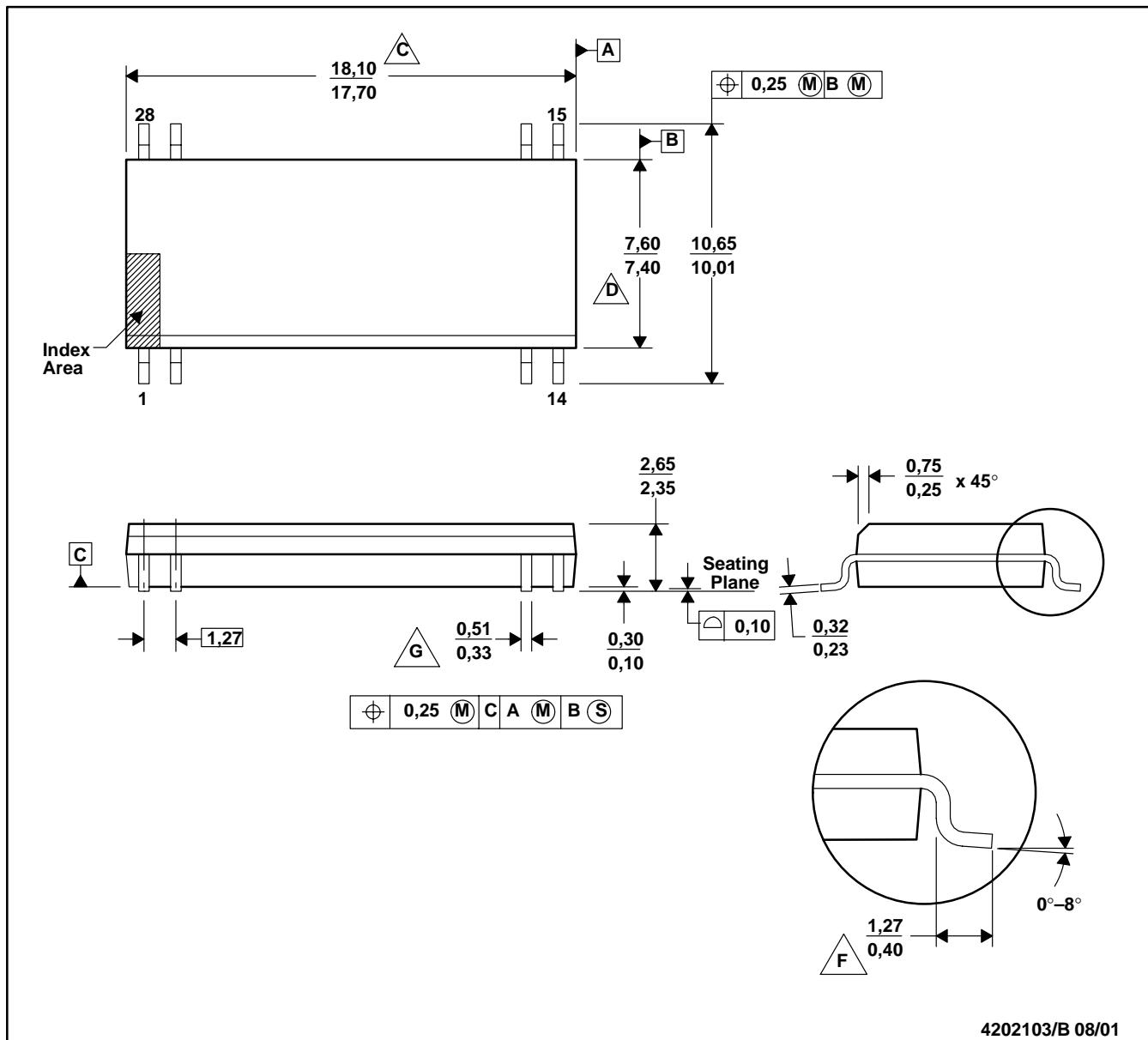
**TUBE**


\*All dimensions are nominal

| Device     | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| ISO122JP   | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122JP.A | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122JPE4 | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122JU   | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |
| ISO122JU.A | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |
| ISO122JUE4 | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |
| ISO122P    | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122P.A  | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122PE4  | NVF          | PDIP         | 8    | 25  | 506    | 13.97  | 11230  | 4.32   |
| ISO122U    | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |
| ISO122U.A  | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |
| ISO122UE4  | DVA          | SOIC         | 8    | 20  | 507    | 12.83  | 5080   | 6.6    |

## DVA (R-PDSO-G8/28)

## PLASTIC SMALL-OUTLINE



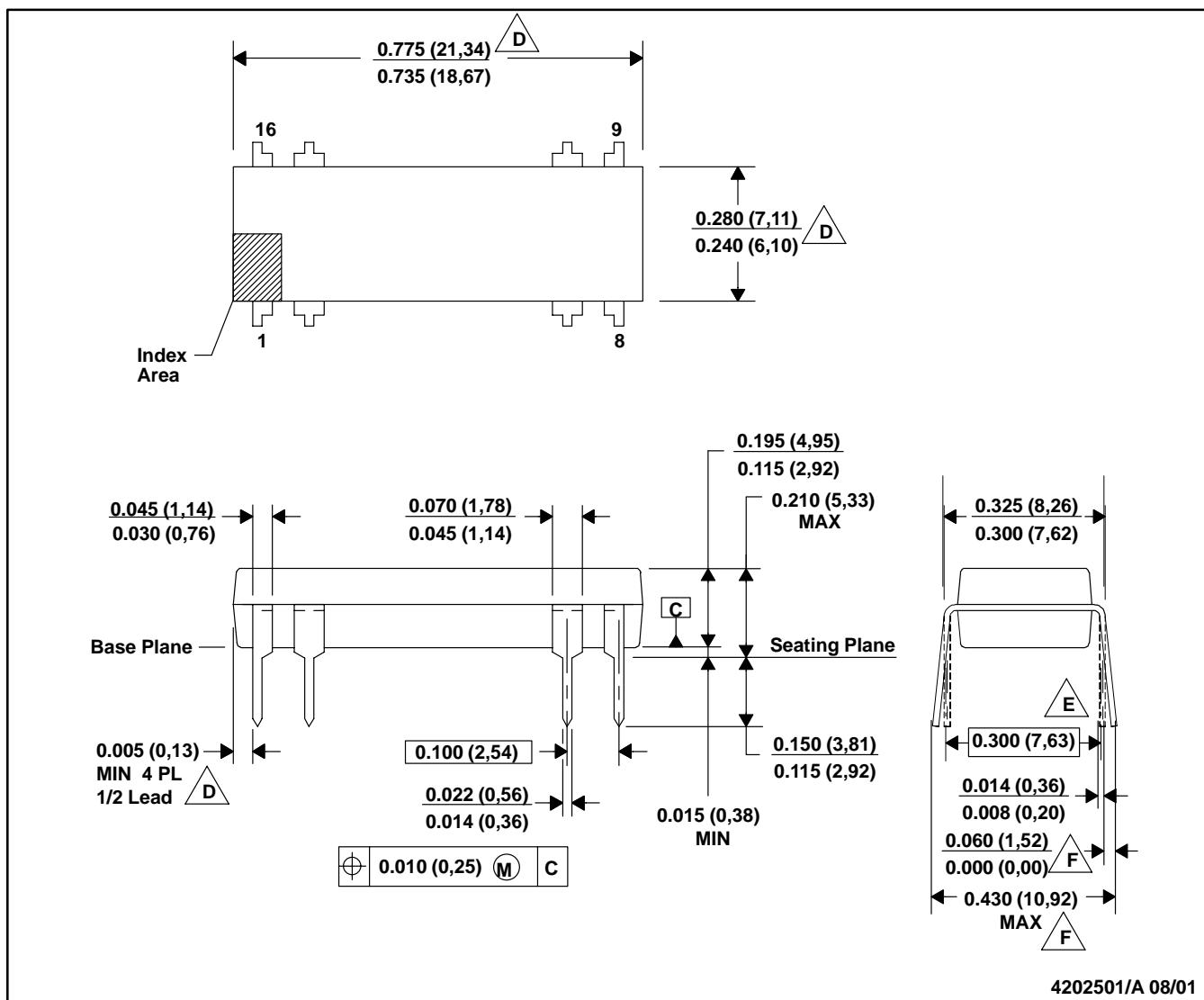
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body length dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, and gate burrs shall not exceed 0,15 mm per side.
- D. Body width dimension does not include inter-lead flash or protrusions. Inter-lead flash and protrusions shall not exceed 0,25 mm per side.
- E. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the cross-hatched area.
- F. Lead dimension is the length of terminal for soldering to a substrate.

- G. Lead width, as measured 0,36 mm or greater above the seating plane, shall not exceed a maximum value of 0,61 mm.
- H. Lead-to-lead coplanarity shall be less than 0,10 mm from seating plane.
- I. Falls within JEDEC MS-013-AE with the exception of the number of leads.

## NVF (R-PDIP-T8/16)

## PLASTIC DUAL-IN-LINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001-BB with the exception of lead count.
  - D. Dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 (0,25).
  - E. Dimensions measured with the leads constrained to be perpendicular to Datum C.
  - F. Dimensions are measured at the lead tips with the leads unconstrained.
- G. A visual index feature must be located within the cross-hatched area.



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